

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10609493	SHINOTSUKA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Carter, Aaron W	2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	274	10/24/06	AWC
250	205	10/24/06	AWC
345	20	10/24/06	AWC
348	251	10/24/06	AWC
358	461	10/24/06	AWC
Updated Above Search		1/2/07	AWC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST Text Search (USPAT, PGPUB, IBM, EPO) See Search History Printout	10/24/06	AWC
Inventor Name Search (See PALM Search History Printout, Check Marks Indicate Applications Considered)	10/24/06	AWC
IEEE Text and Author Search, See Search History Printout	10/24/06	AWC
Interference Search History Printout	1/2/07	AWC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
PGPUB Text Search		1/2/07	AWC